

Search Notes



Application/Control No.

10/669,144

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

TROCKI ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	93.01 118	10/1/2006	<i>mlh.</i>
	121 131		
	151 152		
	154 181		
	187 218		
	228 533		
	534 535		
600	431		
	432		
128	dig. 1		
	dig. 12		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor name search	3/20/2006	<i>mlh.</i>
EAST text search	10/1/2006	<i>mlh.</i>